Power LDMOS transistor

Rev. 3 — 12 July 2013

Product data sheet

1. Product profile

1.1 General description

250 W LDMOS power transistor for base station applications at frequencies from 2110 MHz to 2170 MHz.

Table 1. Typical performance

Typical RF performance at T_{case} = 25 °C in a common source class-AB production test circuit.

Mode of operation	f	I _{Dq}	V_{DS}	$P_{L(AV)}$	Gp	η_D	ACPR
	(MHz)	(mA)	(V)	(W)	(dB)	(%)	(dBc)
2-carrier W-CDMA	2110 to 2170	1900	28	70	18.5	31	-30 <mark>[1]</mark>

Test signal: 3GPP; test model 1; 64 DPCH; PAR = 8.4 dB at 0.01 % probability on CCDF; carrier spacing 5 MHz.

1.2 Features and benefits

- Excellent ruggedness
- High efficiency
- Low R_{th} providing excellent thermal stability
- Designed for low memory effects providing excellent pre-distortability
- Internally matched for ease of use
- Integrated ESD protection
- Compliant to Directive 2002/95/EC, regarding Restriction of Hazardous Substances (RoHS)

1.3 Applications

 RF power amplifiers for W-CDMA base stations and multi carrier applications in the 2110 MHz to 2170 MHz frequency range



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2. Pinning information

Pin	Description		Simplified outline	Graphic symbol
BLF7G2	2L-250P (SOT539A)			
1	drain1			
2	drain2			
3	gate1		5	3
4	gate2		3 4	
5	source	<u>[1]</u>		
				sym117
BLF7G2	2LS-250P (SOT539B)			sym117
BLF7G2 1	2LS-250P (SOT539B) drain1			sym117
				sym117
1	drain1		5	
1 2	drain1 drain2			sym117

[1] Connected to flange.

3. Ordering information

Table 3. Ordering information						
Type number	Packag	Package				
	Name	Description	Version			
BLF7G22L-250P	-	Flanged balanced LDMOST ceramic package; 2 mounting holes; 4 leads	SOT539A			
BLF7G22LS-250P	-	Earless flanged LDMOST ceramic package; 4 leads	SOT539B			

4. Limiting values

Table 4. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
V _{DS}	drain-source voltage		-	65	V
V _{GS}	gate-source voltage		-0.5	+13	V
I _D	drain current		-	65	А
T _{stg}	storage temperature		-65	+150	°C
Tj	junction temperature		-	200	°C

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5. Thermal characteristics

Table 5.	Thermal characteristics			
Symbol	Parameter	Conditions	Тур	Unit
R _{th(j-c)}	thermal resistance from junction to case	$\begin{array}{l} T_{case} = 80 \ ^{\circ}C; \ P_{L} = 70 \ W; \\ V_{DS} = 28 \ V; \ I_{Dq} = 1900 \ mA \end{array}$	0.20	K/W

6. Characteristics

Table 6. Characteristics

 $T_i = 25$ °C unless otherwise specified.

$V_{(BR)DSS}$ drain-source breakdown voltage $V_{GS} = 0$ V; $I_D = 1.8$ mA65V $V_{GS(th)}$ gate-source threshold voltage $V_{DS} = 10$ V; $I_D = 180$ mA1.51.92.3V I_{DSS} drain leakage current $V_{GS} = 0$ V; $V_{DS} = 28$ V2.8 μ I_{DSX} drain cut-off current $V_{GS} = V_{GS(th)} + 3.75$ V; $V_{DS} = 10$ V2834.2-A I_{GSS} gate leakage current $V_{GS} = 11$ V; $V_{DS} = 0$ V280nu g_{fs} forward transconductance $V_{DS} = 10$ V; $I_D = 9$ A-13.7-S	1) = 20 0						
$ \begin{array}{lllllllllllllllllllllllllllllll$	Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$ \begin{array}{lllllllllllllllllllllllllllllll$	$V_{(BR)DSS}$	drain-source breakdown voltage	V_{GS} = 0 V; I_D = 1.8 mA	65	-	-	V
$ I_{DSX} drain cut-off current \qquad V_{GS} = V_{GS(th)} + 3.75 \text{ V}; \qquad 28 \qquad 34.2 - \qquad A \\ V_{DS} = 10 \text{ V} \qquad $	V _{GS(th)}	gate-source threshold voltage	$V_{DS} = 10 \text{ V}; I_{D} = 180 \text{ mA}$	1.5	1.9	2.3	V
$\label{eq:VDS} \begin{array}{c} V_{DS} = 10 \ V \\ \hline \\ I_{GSS} & \mbox{gate leakage current} & V_{GS} = 11 \ V; \ V_{DS} = 0 \ V & - & - & 280 \ n. \\ \hline \\ g_{fs} & \mbox{forward transconductance} & V_{DS} = 10 \ V; \ I_D = 9 \ A & - & 13.7 \ - & S \\ \hline \\ R_{DS(on)} & \mbox{drain-source on-state resistance} & V_{GS} = V_{GS(th)} + 3.75 \ V; & - & 0.081 \ - & \Omega \end{array}$	I _{DSS}	drain leakage current	$V_{GS} = 0 V; V_{DS} = 28 V$	-	-	2.8	μA
$\begin{array}{c} g_{fs} & \text{forward transconductance} & V_{DS} = 10 \text{ V}; \text{ I}_{D} = 9 \text{ A} & - & 13.7 & - & S \\ \hline R_{DS(on)} & \text{drain-source on-state resistance} & V_{GS} = V_{GS(th)} + 3.75 \text{ V}; & - & 0.081 & - & \Omega \end{array}$	I _{DSX}	drain cut-off current	(-)	28	34.2	-	А
$R_{DS(on)}$ drain-source on-state resistance $V_{GS} = V_{GS(th)} + 3.75 V$; - 0.081 - Ω	I _{GSS}	gate leakage current	$V_{GS} = 11 V; V_{DS} = 0 V$	-	-	280	nA
	g _{fs}	forward transconductance	$V_{DS} = 10 \text{ V}; I_D = 9 \text{ A}$	-	13.7	-	S
	R _{DS(on)}	drain-source on-state resistance		-	0.081	-	Ω

7. Test information

Table 7. Functional test information

Mode of operation: 2-carrier W-CDMA; PAR = 8.4 dB at 0.01 % probability on the CCDF; 3GPP test model 1; 1-64 DPCH; $f_1 = 2112.5$ MHz; $f_2 = 2117.5$ MHz; $f_3 = 2162.5$ MHz; $f_4 = 2167.5$ MHz; RF performance at $V_{DS} = 28$ V; $I_{Dq} = 1900$ mA; $T_{case} = 25$ °C; unless otherwise specified; in a class-AB production test circuit.

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$P_{L(AV)}$	average output power		-	70	-	W
Gp	power gain	$P_{L(AV)} = 70 \text{ W}$	17	18.5	-	dB
RL _{in}	input return loss	$P_{L(AV)} = 70 \text{ W}$	-	-15	-5	dB
η_D	drain efficiency	$P_{L(AV)} = 70 \text{ W}$	27	31	-	%
ACPR	adjacent channel power ratio	$P_{L(AV)} = 70 \text{ W}$	-	-30	-25	dBc

7.1 Ruggedness in class-AB operation

The BLF7G22L-250P and BLF7G22LS-250P are capable of withstanding a load mismatch corresponding to VSWR = 10 : 1 through all phases under the following conditions: V_{DS} = 30 V; I_{Dq} = 1900 mA; P_L = 250 W (CW); f = 2110 MHz to 2170 MHz.

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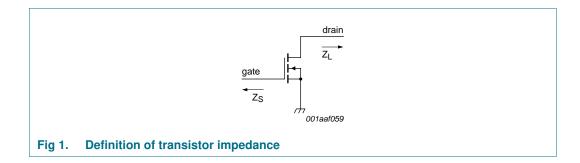
7.2 Impedance information

Table 8. Typical impedance

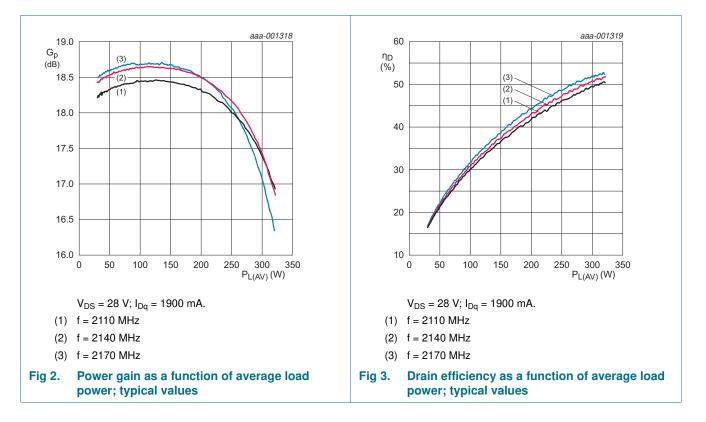
Measured load-pull data half device; $I_{Dq} = 1900 \text{ mA}$; $V_{DS} = 28 \text{ V}$.

f	Z _S [1]	ZL ^[1]
(MHz)	(Ω)	(Ω)
2050	1.50 – j5.20	3.03 – j2.92
2110	2.08 – j5.64	2.76 – j2.70
2140	2.16 – j5.89	2.31 – j2.74
2170	2.43 – j5.97	2.31 – j2.74
2230	3.94 – j7.60	2.10 – j2.96

[1] Z_S and Z_L defined in Figure 1.

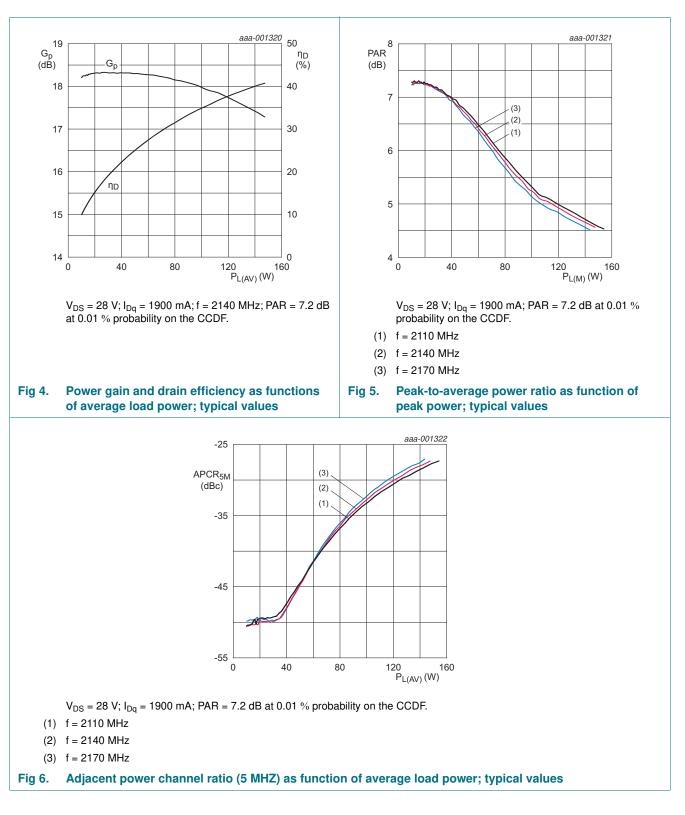


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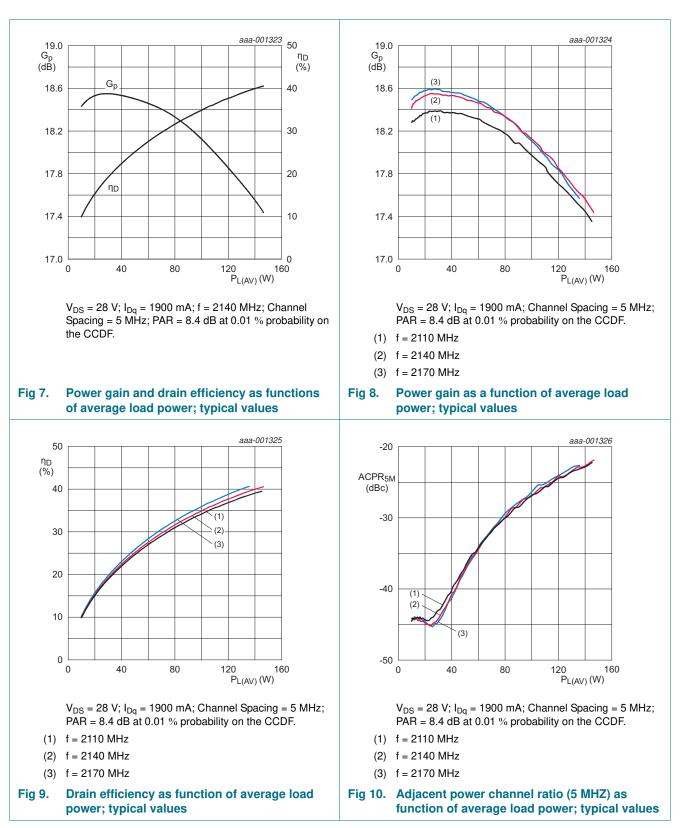
7.3 1 Tone CW

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7.4 1-carrier W-CDMA

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7.5 2-carrier W-CDMA

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7.6 Test circuit

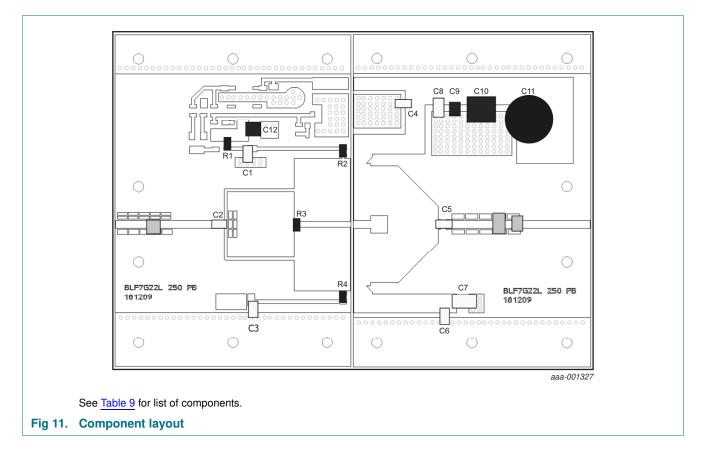


Table 9.List of componentsSee Figure 11 for component layout.

Component	Description	Value	Remarks
C2	multilayer ceramic chip capacitor	8.2 pF	11 ATC100A
C1, C3, C4, C5, C6	multilayer ceramic chip capacitor	8.2 pF	2 ATC100B
C7, C8	multilayer ceramic chip capacitor	470 nF	3 TDK
C9, C12	multilayer ceramic chip capacitor	4.7 μF	3 TDK
C10	multilayer ceramic chip capacitor	10 μF	3 TDK
C11	electrolytic capacitor	470 μF	
R1	chip resistor	4.7 Ω	Philips 0603
R2, R4	chip resistor	10 Ω	Philips 0603
R3	chip resistor	33 Ω	Philips 0603

[1] American Technical Ceramics type 100A or capacitor of same quality.

[2] American Technical Ceramics type 100B or capacitor of same quality.

[3] TDK or capacitor of same quality.

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8. Package outline

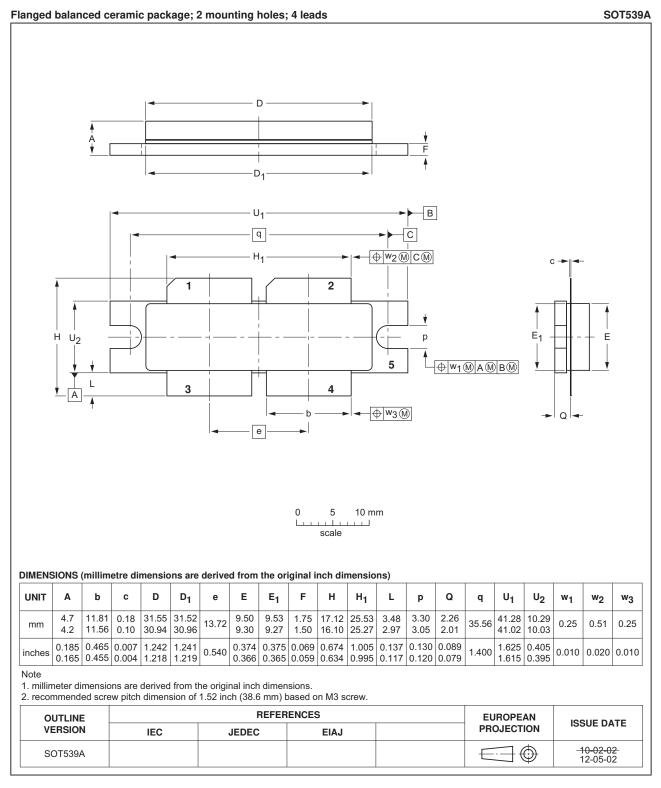


Fig 12. Package outline SOT539A

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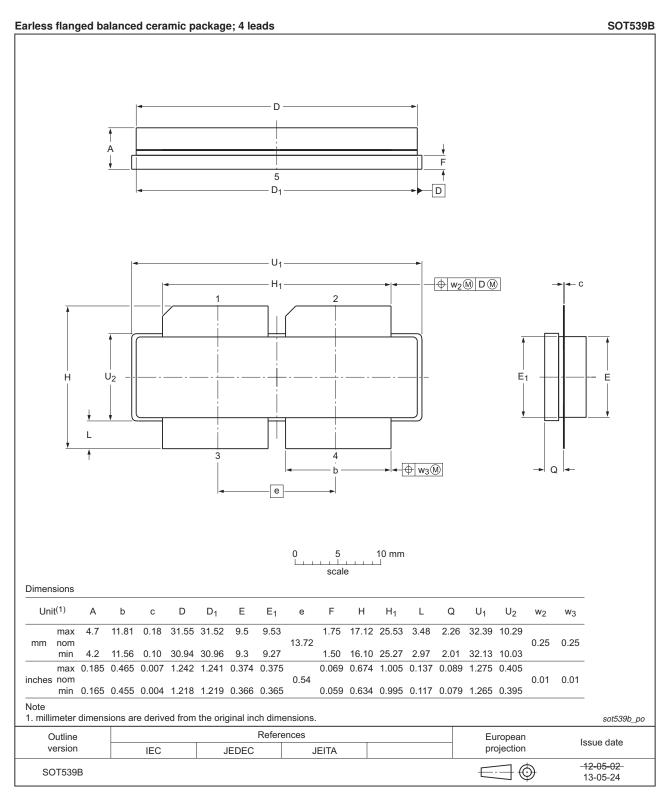


Fig 13. Package outline SOT539B

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9. Handling information

CAUTION



This device is sensitive to ElectroStatic Discharge (ESD). Observe precautions for handling electrostatic sensitive devices.

Such precautions are described in the ANSI/ESD S20.20, IEC/ST 61340-5, JESD625-A or equivalent standards.

10. Abbreviations

Table 10.	Abbreviations
Acronym	Description
3GPP	Third Generation Partnership Project
CCDF	Complementary Cumulative Distribution Function
CW	Continuous Wave
DPCH	Dedicated Physical CHannel
LDMOS	Laterally Diffused Metal Oxide Semiconductor
LDMOST	Laterally Diffused Metal Oxide Semiconductor Transistor
PAR	Peak-to-Average power Ratio
RF	Radio Frequency
VSWR	Voltage Standing Wave Ratio
W-CDMA	Wideband Code Division Multiple Access

11. Revision history

Table 11. Revision history

Table II. Revision history				
Document ID	Release date	Data sheet status	Change notice	Supersedes
BLF7G22L-250P_22LS-250P v.3	20130712	Product data sheet	-	BLF7G22L-250P_22LS-250P v.2
Modifications:		age outline <u>Figure 13</u> on disclaimer added to	-	
BLF7G22L-250P_22LS-250P v.2	20111028	Product data sheet	-	BLF7G22L-250P_22LS-250P v.1
Modifications:	Table 1 o	is of this document has n page 1: the term PD n changed	•	o Product data sheet nanged to DPCH; several values
		n page 3: the term PD n changed	PCH has been ch	nanged to DPCH; several values
	 Section 7 	2.2 on page 4: section	has been added	
	 Section 7 	.6 on page 8: section	has been added	
	 Section 9 	on page 11: section h	as been added	
BLF7G22L-250P_22LS-250P v.1	20100506	Objective data sheet	-	-

12. Legal information

12.1 Data sheet status

Document status[1][2]	Product status ^[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

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[2] The term 'short data sheet' is explained in section "Definitions".

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